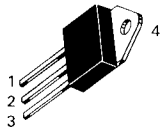


ALPHANUMERIC INDEX — CROSS-REFERENCE (Continued)

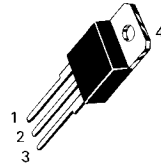
Industry Part Number	Motorola Direct Replacement	Motorola Similar Replacement	Page Number	Industry Part Number	Motorola Direct Replacement	Motorola Similar Replacement	Page Number
BDX10C	2N3055A		3-9	BDY93	BU326A		3-363
BDX18	MJ2955		3-6	BDY93/01	BU326A		3-363
BDX33	BDX33		3-334	BDY94	BU326A		3-363
BDX33A	BDX33A		3-334	BDY94/01	BU326A		3-363
BDX33B	BDX33B		3-334	BDY96	BUX47		3-499
BDX33C	BDX33C		3-334	BDY96-1	BUX47		3-499
BDX33D	BDX33D		3-334	BDY96/01	BUX47		3-499
BDX34	BDX34		3-334	BDY97	BUX47		3-499
BDX34A	BDX34A		3-334	BDY97-1	BUX47		3-499
BDX34B	BDX34B		3-334	BF380	MPS-U10		3-1052
BDX34C	BDX34C		3-334	BF380-5	MPS-U10		3-1052
BDX34D	BDX34D		3-334	BF381	MPS-U10		3-1052
BDX35	TIP42C		3-1083	BF382	MPS-U10		3-1052
BDX36	TIP42D		3-1083	BF382-5	MPS-U10		3-1052
BDX37	TIP42D		3-1083	BU104P	BU406		3-366
BDX42	BD775		—	BU105		MJ12003	3-642
BDX43	BD777		3-302	BU108	BU208		3-343
BDX44	BD779		3-302	BU109P	BU407		3-366
BDX45	BD776		3-302	BU124	BU426		3-368
BDX46	BD778		3-302	BU126		MJE13005	3-944
BDX47	BD779		3-302	BU126A		MJE13005	3-944
BDX53	BDX53		3-338	BU134	MJ423		3-524
BDX53A	BDX53A		3-338	BU137		MJ10025	3-623
BDX53B	BDX53B		3-338	BU157		MJ10025	3-623
BDX53C	BDX53C		3-338	BU180		MJE5741	3-914
BDX53D	BDX53D		3-338	BU180A		MJE5742	3-914
BDX54	BDX54		3-338	BU204	BU207		3-343
BDX54A	BDX54A		3-338	BU205	BU208		3-343
BDX54B	BDX54B		3-338	BU205A		MJ12003	3-642
BDX54C	BDX54C		3-338	BU207	BU207		3-343
BDX54D	BDX54D		3-338	BU208	BU208		3-343
BDX70		2N6487	3-207	BU208A	BU208A		3-348
BDX71		2N6487	3-207	BU208D	BU208D		3-353
BDX72		2N6488	3-207	BU221	BU326A		3-363
BDX73		2N6488	3-207	BU222	BU326A		3-363
BDX74		2N6486	3-207	BU223	MJ431		3-524
BDX75		2N6486	3-207	BU223A	MJ431		3-524
BDX77	BD799		3-312	BU322	BU323		3-355
BDX78	BD800		3-314	BU322A	BU323A		3-355
BDX83	MJ3000		3-530	BU323	BU323A		3-355
BDX83A	MJ3000		3-530	BU323A	BU323A		3-355
BDX83B	MJ3001		3-530	BU323AP	BU323AP		3-359
BDX83C	2N6284		3-172	BU323P	BU323P		3-359
BDX84	MJ2500		3-530	BU326	BU326A		3-363
BDX84A	MJ2500		3-530	BU326A	BU326A		3-363
BDX84B	MJ2501		3-530	BU406	BU406		3-366
BDX84C	2N6287		3-172	BU406D	BU406D		3-366
BDX91	2N3715		3-26	BU407	BU407		3-366
BDX92	2N3791		3-56	BU407D	BU407D		3-366
BDX93	2N3716		3-26	BU426	BU426		3-368
BDX94	2N3792		3-56	BU426A	BU426A		3-368
BDX95		2N5882	3-123	BU433	BU426		3-368
BDX96	2N5880		3-123	BU500		MJ12005	3-650
BDY29	2N5303		3-93	BU508	BU508		3-372
BDY34	BD785		3-304	BU508A	BU508A		3-372
BDY37	2N3773		3-52	BU508AD	BU508AD		3-372
BDY80		2N6122	3-154	BU508D	BU508D		3-372
BDY81		2N6122	3-154	BU522	BU522		3-377
BDY82		2N6125	3-154	BU522A	BU522A		3-377
BDY83		2N6125	3-154	BU522B	BU522B		3-377

*Consult Motorola if a direct replacement is necessary.

TABLE 4 — PLASTIC TO-218



STYLE 1:
PIN 1. BASE
2. COLLECTOR
3. EMITTER
4. COLLECTOR



STYLE 1:
PIN 1. BASE
2. COLLECTOR
3. EMITTER
4. COLLECTOR

CASE 340-02 (TO-218AC)

IC Cont Amps Max	V _{CEO(sus)} Volts Min	Device Type		h _{FE} Min/Max	@ I _C Amp	Resistive Switching			f _T MHz Min	P _D (Case) Watts @ 25°C
		NPN	PNP			t _s μs Max	t _f μs Max	@ I _C Amp		
3	750	MJH16032		4 min	3	2	1.5	2		125
	850	MJH16034		4 min	3	2	1.5	2		125
5	400	BUW11		6 min	3	4	0.8	3		125
	450	BUW11A		6 min	2.5	4	0.8	2.5		125
		MJH16002		5 min	5	3	0.3	3		100
		MJH16004		7 min	5	2.7	0.35	3		100
	500	MJH16002A		5 min	5	3	0.3	3		100
6	1500*	MJH12004		2.5 min	4.5	—	1	4.5	4	100
	375	BU426†		30 typ	0.6	2 typ	0.5 typ	2.5	6 typ	113
8	400	BUW12		6 min	6	4	0.8	5		125
		MJH16106		6/25	8	2 typ	0.1 typ	5		125
9	450	BUW12A		6 min	5	4	0.8	5		125
		MJH16006		5 min	8	2.5	0.25	5		125
		MJH16008		7 min	8	2.2	0.25	5		125
	500	BUT50P##†		30 min	2	0.75 typ	0.1 typ	5		100
		MJH16006A		5 min	8	2.5	0.25	5		125
10	700	BU508,A		2.25 min	4.5	8 typ	0.5 typ	4.5	7	125
		BU508D,AD		2.25 min	4.5	8 typ	0.5 typ	4.5	7	125
15	750	MJH12005					0.4 typ	5	4	100
	400	BUV47†		7 min	5	2	0.4	6		128
15	450	BUV47A†		7 min	6	2	0.4	6		128
10	40	TIP33	TIP34	20 min	3				3	80
	60	BDV65##†	BDV64##†	1k min	5					125
		TIP33A	TIP34A	20 min	3				3	80
		TIP140##	TIP145##	500 min	10	2.5 typ	2.5 typ	5	4#	125
	80	BDV65A##†	BDV64A##†	1k min	5					125
		TIP33B	TIP34B	20 min	3				3	80
		TIP141##	TIP146##	500 min	10	2.5 typ	2.5 typ	5	4#	125
	100	BDV65B##†	BDV64B##†	1k min	5					125
		TIP33C	TIP34C	20 min	3				3	80
		TIP142##	TIP147##	500 min	10	2.5 typ	2.5 typ	5	4#	125
15	120	BDV65C##†	BDV64C##†	1k min	5					125
	200	BU323P##†		150 min	6	15	15	6		125
	250	BU323AP##†		150 min	6	15	15	6		125
	400	MJH10012##		100/2k	6	15	15	6		118
	800	MJH16018		4 min	5	4.5 typ	0.2 typ	5		150
	60	TIP3055	TIP2955	5 min	10				2.5	80
	150	MJH11018##	MJH11017##	400/15k	10				3#	150
15	200	MJH11020##	MJH11019##	400/15k	10				3#	150
	250	MJH11022##	MJH11021##	400/15k	10				3#	150

[h_{FE}] @ 1 MHz, ## Darlington

* V_{(BR)CEX} or V_{(BR)CES}

† These devices supplied in Case 340D-01. Consult Motorola for details.

(continued)

TABLE 14 — SWITCHMODE POWER TRANSISTORS (continued)

V _{CEO(sus)} Volts Min	I _C Cont Amps Max	V _{CEV} Volts Min	Device Type NPN unless otherwise noted	h _{FE} Min/Max	@ I _C Amp	Resistive Switching			f _T MHz Min	P _D (Case) Watts @ 25°C	Case JEDEC/MOT
						t _s μs Max	t _f μs Max	@ I _C Amp			
750	3	1500 1500	MJE16032 MJH16032	4 min 4 min	3 3	2 2	1.5 1.5	2 2		80 125	TO-220/221A TO-218/340
	2.5	1500 1500	MJ12002★ MJE12007★	1.11 min 1.1 min	2 2		1 1	2 2	4 typ 4 typ		TO-204/1 TO-220/221A
700	40	1000	BUT35##	15 min	24	4	1.2	24		250	TO-204/197
	20	1000	BUT15##	15 min	12	2.5	0.8	12		175	TO-204/1
	10	1200	MJ8504★	7.5 min	1.5	4	2	5			TO-204/1
	8	1400 1500 1500	MJ10011# BU508,A BU508D,AD	20 min 2.25 min 2.25 min	4 4.5 4.5	1 8 typ 8 typ	1 0.5 typ 0.5 typ	4 4.5 4.5			TO-204/1 TO-218/340 TO-218/340
		1200 1200 1500 1500	MJ8502★ MJE8502★ BU208A BU208D	7.5 min 7.5 min 2.25 min 2.25 min	1 1 4.5 4.5	4 4 8 typ	2 2 0.4 typ 0.6 typ	2.5 2.5 4.5 4.5	4 typ	90	TO-204/1 TO-220/221A TO-204/1 TO-204/1
	2.5	1200	MJE8500★	7.5 min	0.5	4	2	1			TO-220/221A
	600	10	700	MJ10014##★	10/250	10	2.5	0.8	10		TO-204/1
500	50	750 850	MJ10016##★ BUT34##	10 min 15 min	40 32	2.5 3	1 1.5	20 32		250	TO-204/197 TO-204/197
	25	850	BUT14##	15 min	16	2.8	0.8	16		175	TO-204/1
	20	600 800	MJ10009##★ MJ13335★	30/300 10/60	10 5	2 4	0.6 0.7	10 10	8**		TO-204/1 TO-204/1
		850 1000 1000	BUT51P## MJ16010A★ MJH16010A★	40 min 5 min 5 min	5 15 15	1.1 3 3	0.16 0.4 0.4	10 10 10		125	TO-218/340D TO-204/1 TO-218/340
	8	850 1000 1000	BUT50P## MJ16006A★ MJH16006A★	30 min 5 min 5 min	2 15 15	0.75 typ 3 3	0.1 typ 0.4 0.4	5 10 10		100	TO-218/340D TO-204/1 TO-218/340
		1000 1000	MJ16002A★ MJH16002A★	5 min 5 min	15 15	3 3	0.3 0.3	3 3			TO-204/1 TO-218/340
	5	1000 1000									
450	30	850 850 1000	MJ16020 MJ16022 BUS98A	5 min 7 min 8 min	30 30 16	1.8 1.5 2.3	0.2 0.15 0.4	20 20 16		250 250 250	TO-204/1 TO-204/1 TO-204/197
	20	650	MJ10008##★	30/300	10	2	0.6	10	8**		TO-204/1
		850	2N6837★	10/30	15	2.5	0.25	15	15		TO-204/1
		850	MJ16014★	5 min	20	2.7	0.35	20			TO-204/197
		850	MJ16016★	7 min	20	2.2	0.25	20			TO-204/197
	15	850	2N6836★	10/30	10	3	0.35	10	10		TO-204/1
		850	MJ12022★	5 min	15		0.1 typ	10			TO-204/1
		850	MJ16010★	5 min	15	1.2 typ	0.2 typ	10			TO-204/1
		850	MJ16012★	7 min	15	0.9 typ	0.15 typ	10			TO-204/1
		850 850 850 1000	MJH16010★ MJH16012★ BUX48A	5 min 7 min 8 min	15 15 10	1.2 0.9 2	0.2 0.15 0.4	10 10 10		175 150 175	TO-218/340 TO-218/340 TO-204/1

★ Designers Data Sheet characterization

Darlington

Darlington with speed-up diode

* t_{off}

** |h_{FE}| @ 1 MHz

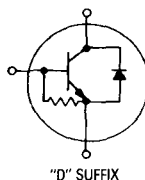
(continued)

NPN Silicon Power Transistors

Horizontal Deflection

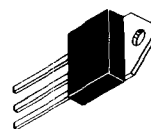
... specifically designed for use in large screen color deflection circuits.

- Glass Passivated (Patented Photoglass)
- Triple Diffused Mesa Technology for Long Term Stability
- Collector-Emitter Voltage — $V_{CE} = 1500 \text{ Vdc}$
- Collector-Emitter Sustaining Voltage — $V_{CEO(sus)} = 700 \text{ Vdc}$
- Switching Times with Inductive Loads, $t_f = 0.5 \mu\text{s}$ (Typ) @ $I_C = 4.5 \text{ A}$
- Optimum Drive Condition Curves
- Glass Base-Collector Junction
- TO-218 Package for Low Cost Mounting
- Available with Internal Flyback Diode, "D" Suffix



BU508
BU508D
BU508A
BU508AD

POWER TRANSISTORS
8 AMPERES
1500 VOLTS



CASE 340-02
TO-218AC

MAXIMUM RATINGS

Rating	Symbol	All Parts	Unit
Collector-Emitter Voltage	$V_{CEO(sus)}$	700	Vdc
Collector-Emmitter Voltage	V_{CES}	1500	Vdc
Emitter Base Voltage	V_{EB}	5	Vdc
Collector Current — Continuous	I_C	8	Adc
Peak ⁽¹⁾	I_{CM}	15	
Base Current — Continuous	I_B	4	Adc
Peak ⁽¹⁾	I_{BM}	6	
Total Power Dissipation @ $T_C = 25^\circ\text{C}$	P_D	125	Watts
Derate above 25°C		1	W/ $^\circ\text{C}$
Operating and Storage Temperature Range	T_J, T_{stg}	-65 to +150	$^\circ\text{C}$

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	1	$^\circ\text{C/W}$
Maximum Lead Temperature for Soldering Purposes, 1/8" from Case for 5 seconds	T_L	275	$^\circ\text{C}$

(1) Pulse Test: Pulse Width = 5 ms, Duty Cycle $\leq 10\%$.

BU508, BU508D, BU508A, BU508AD

ELECTRICAL CHARACTERISTICS (T_C = 25° unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
----------------	--------	-----	-----	-----	------

OFF CHARACTERISTICS(1)

Collector-Emitter sustaining voltage (I _C = 100 mAdc, I _B = 0)	V _{CE(sus)}	700	—	—	Vdc
Collector Cutoff Current (V _{CE} = 1500 Vdc, V _{BE} = 0, T _C = 25°C) (V _{CE} = 1500 Vdc, V _{BE} = 0, T _C = 125°C)	I _{CES}	— —	— —	0.1 2	mAdc
Emitter Base Leakage (V _{EB} = 6 V, I _C = 0)	I _{EBO}	—	—	10, 300	mAdc

ON CHARACTERISTICS(1)

DC Current Gain (I _C = 4.5 Adc, V _{CE} = Vdc)	h _{FE}	2.25	—	—	—
Collector-Emitter Saturation Voltage (I _C = 4.5 Adc, I _B = 2 Adc)	V _{CE(sat)}	—	—	3 1	Vdc
Base Emitter Saturation Voltage (I _C = 4.5 Adc, I _B = 2 Adc)	V _{BE(sat)}	—	—	1.3	Vdc
Second Breakdown Collector Current with Base Forward Biased	I _{S/b}	See Figure 11			

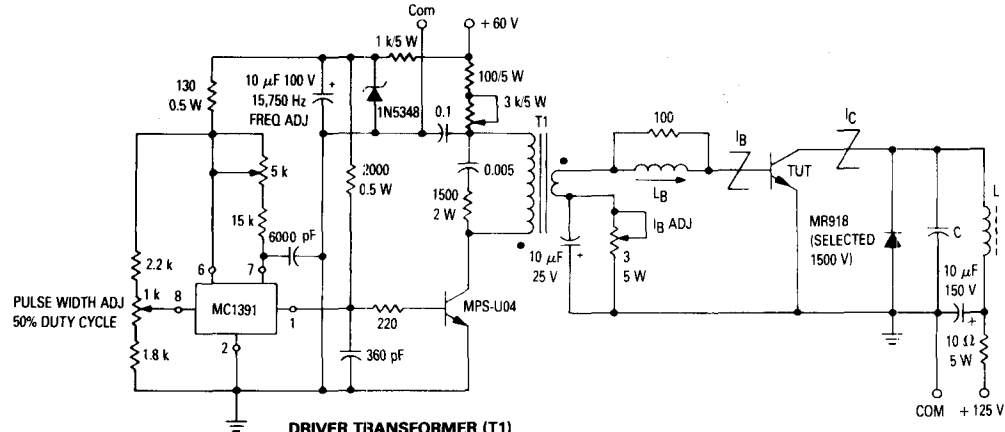
DYNAMIC CHARACTERISTICS

Current-Gain — Bandwidth Product (I _C = 0.1 Adc, V _{CE} = 5 Vdc, f _{test} = 1 MHz)	f _T	—	7	—	MHz
Output Capacitance (V _{CB} = 10 Vdc, I _E = 0, f = 0.1 MHz)	C _{ob}	—	125	—	pF

SWITCHING CHARACTERISTICS

Fall Time (I _C = 4.5 Adc, I _B = 1.8 Adc, LB = 10 μH, see Figure 1)	t _s t _f	—	8 0.5	—	μs
--	----------------------------------	---	----------	---	----

(1) Pulse Test: Pulse Width = 5 ms, Duty Cycle ≤ 10%.



I _C A	L mH	C μF
3.5	0.87	0.013
4.5	0.67	0.017

DRIVER TRANSFORMER (T1)

- Ferroxcube pot core #4229P-L00-3C8
- Adjust gap for primary inductance L_p = 70 mH (approximately 5 mil spacer)
- Primary 230T #28 AWG (5 layers)
- Secondary 15T #22 AWG (1 layer)
- Secondary leakage inductance should be less than 3 μH
- Use 3 mil mylar tape between each winding layer

Figure 1. Switching Times Test Circuit

BASE DRIVE: The Key to Performance

By now, the concept of controlling the shape of the turn-off base current is widely accepted and applied in horizontal deflection design. The problem stems from the fact that good saturation of the output device, prior to turn-off, must be assured. This is accomplished by providing more than enough I_{B1} to satisfy the lowest gain output device h_{FE} at the end of scan I_{CM} . Worst-case component variations and maximum high voltage loading must also be taken into account.

If the base of the output transistor is driven by a very low impedance source, the turn-off base current will reverse very quickly as shown in Figure 2. This results in rapid, but only partial, collector turn-off, because excess carriers become trapped in the high resistivity collector and the transistor is still conductive. This is a high dissipation mode, since the collector voltage is rising very rapidly. The problem is overcome by adding inductance to the base circuit to slow the base current reversal as shown in Figure 3, thus allowing excess carrier recombination in the collector to occur while the base current is still flowing.

Choosing the right L_B is usually done empirically, since the equivalent circuit is complex, and since there are several important variables (I_{CM} , I_{B1} , and h_{FE} at I_{CM}). One method is to plot fall time as a function of L_B , at the desired conditions, for

several devices within the h_{FE} specification. A more informative method is to plot power dissipation versus I_{B1} for a range of values of L_B . This kind of analysis shows the parameter which really matters is dissipation, whether caused by switching or by saturation. The negative slope of these curves at the left (low I_{B1}) is caused by saturation losses. The positive slope portion at higher I_{B1} , and low values of L_B is due to switching losses as described above. For very low L_B a very narrow optimum is obtained. This occurs when $I_{B1} h_{FE} = I_{CM}$, and therefore would be acceptable only for the "typical" device with constant I_{CM} . As L_B is increased, the curves become broader and flatter above the $I_{B1} h_{FE} = I_{CM}$ point as the turn-off "tails" are brought under control. Eventually, if L_B is raised too far, the dissipation all across the curve will rise, due to poor initiation of switching rather than tailing. Plotting this type of curve family for devices of different h_{FE} , essentially moves the curves to the left or right according to the relation $I_{B1} h_{FE} = \text{constant}$. It then becomes obvious that, for a specified I_{CM} , an L_B can be chosen which will give low dissipation over a range of h_{FE} and/or I_{B1} . The only remaining decision is to pick I_{B1} high enough to accommodate the lowest h_{FE} part specified. Neither L_B nor I_{B1} are absolutely critical, and should be selected for the specific required condition. Similar curves relating to this discussion can be found on Motorola's data sheet for the BU207.

TEST CIRCUIT WAVEFORMS

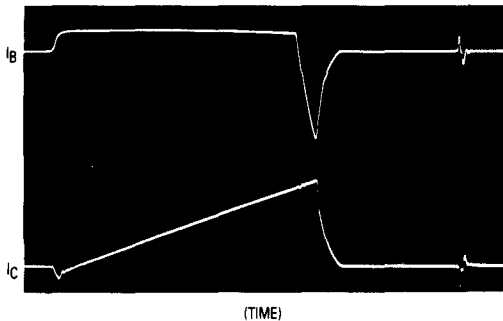


Figure 2.

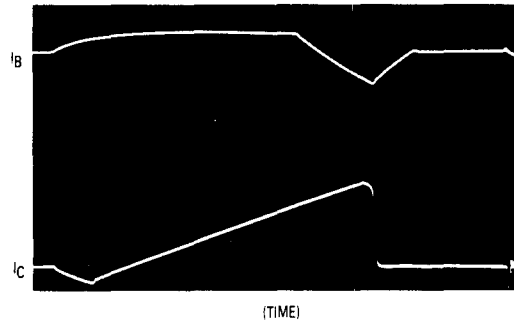


Figure 3.

TEST CIRCUIT OPTIMIZATION

The test circuit may be used to evaluate devices in the conventional manner, i.e., to measure fall time, storage time, and saturation voltage. However, this circuit was designed to evaluate devices by a simple criterion, power supply input. Excessive power input can be caused by a variety of problems, but it is the dissipation in the transistor that is of fundamental impor-

tance. Once the required transistor operating current is determined, fixed circuit values may be selected from the table. Factory testing is performed by reading the current meter only, since the input power is proportional to current. No adjustment of the test apparatus is required.

BU508, BU508D, BU508A, BU508AD

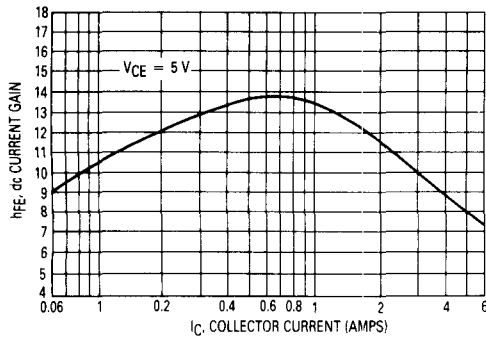


Figure 4. Typical dc Current Gain

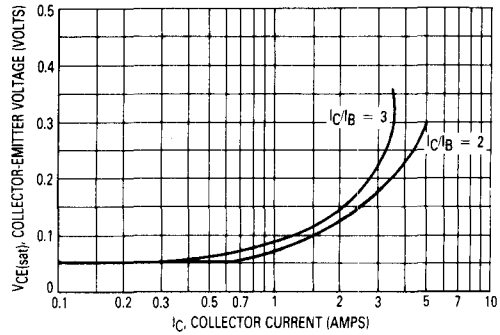


Figure 5. Typical Collector Saturation Voltage

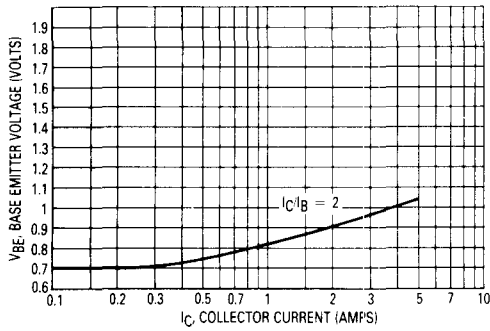


Figure 6. Typical Base Emitter Saturation Voltage

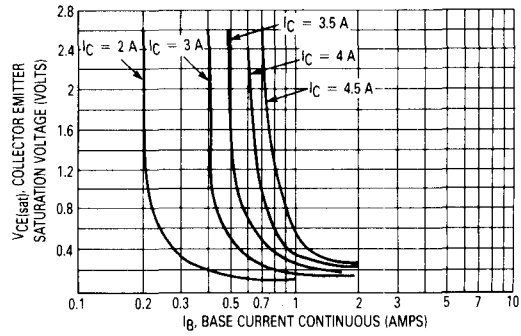


Figure 7. Typical Collector Saturation Region

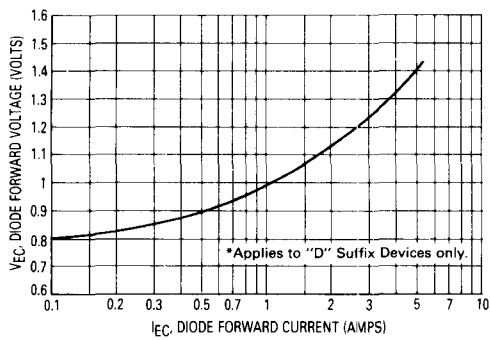


Figure 8. Typical Damper Diode Forward Voltage*

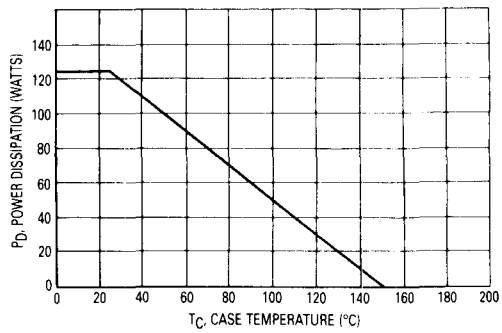


Figure 9. Power-Temperature Derating Curve

BU508, BU508D, BU508A, BU508AD

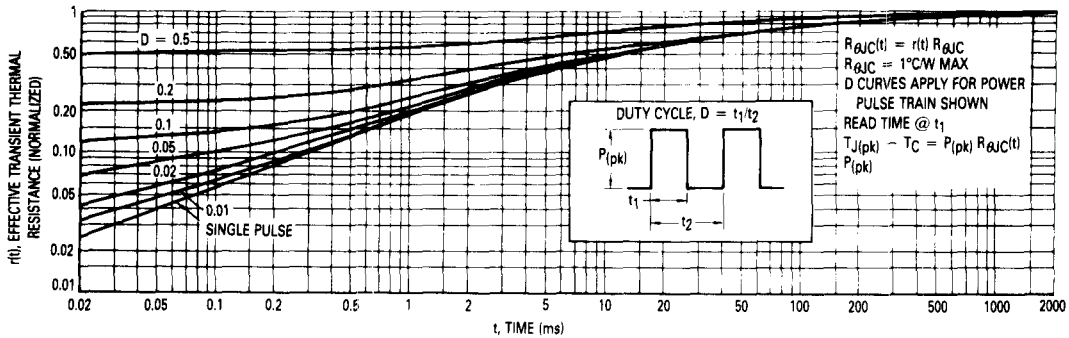


Figure 10. Thermal Response

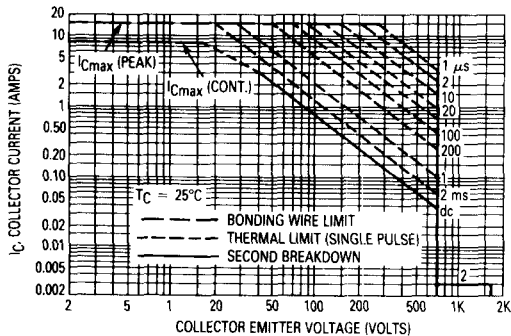


Figure 11. Maximum Forward Biased Safe Operating Area

Note (2) Operation in this area limited to Pulse Width $< 20 \mu\text{s}$,
Duty Cycle < 0.25 , $R_{BE} < 100 \text{ ohms}$

